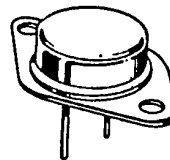


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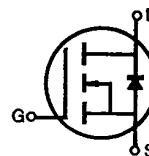
IRF240/241/242/243**N-CHANNEL
POWER MOSFETS****FEATURES**

- Low $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Low input capacitance
- Extended safe operating area
- Improved high temperature reliability
- TO-3 package (Standard)

TO-3

**PRODUCT SUMMARY**

Part Number	V_{DS}	$R_{DS(on)}$	I_D
IRF240	200V	0.18 Ω	18A
IRF241	150V	0.18 Ω	18A
IRF242	200V	0.22 Ω	16A
IRF243	150V	0.22 Ω	16A

**MAXIMUM RATINGS**

Characteristic	Symbol	IRF240	IRF241	IRF242	IRF243	Unit
Drain-Source Voltage (1)	V_{DSS}	200	150	200	150	Vdc
Drain-Gate Voltage ($R_{GS}=1.0M\Omega$) (1)	V_{DGR}	200	150	200	150	Vdc
Gate-Source Voltage	V_{GS}	± 20				Vdc
Continuous Drain Current $T_C=25^\circ C$	I_D	18	18	16	16	Adc
Continuous Drain Current $T_C=100^\circ C$	I_D	11	11	10	10	Adc
Drain Current—Pulsed (3)	I_{DM}	72	72	64	64	Adc
Gate Current—Pulsed	I_{GM}	± 1.5				Adc
Total Power Dissipation @ $T_C=25^\circ C$	P_D	125				Watts
Derate above $25^\circ C$		1.0				W/ $^\circ C$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to 150				$^\circ C$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T_L	300				$^\circ C$

Notes: (1) $T_J=25^\circ C$ to $150^\circ C$ (2) Pulse test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

(3) Repetitive rating: Pulse width limited by max. junction temperature



SAMSUNG SEMICONDUCTOR

IRF240/241/242/243**N-CHANNEL
POWER MOSFETS****ELECTRICAL CHARACTERISTICS** ($T_C=25^\circ\text{C}$ unless otherwise specified).

Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	IRF240	200	—	—	V	$V_{GS}=0V$
		IRF242	—	—	—	—	—
		IRF241 IRF243	150	—	—	V	$I_D=250\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	ALL	2.0	—	4.0	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
Gate-Source Leakage Forward	I_{GSS}	ALL	—	—	100	nA	$V_{GS}=20V$
Gate-Source Leakage Reverse	I_{GSS}	ALL	—	—	-100	nA	$V_{GS}=-20V$
Zero Gate Voltage Drain Current	I_{DSS}	ALL	—	—	250	μA	$V_{DS}=\text{Max. Rating}$, $V_{GS}=0V$
			—	—	1000	μA	$V_{DS}=\text{Max. Rating} \times 0.8$, $V_{GS}=0V$, $T_C=125^\circ\text{C}$
On-State Drain-Source Current (2)	$I_{D(on)}$	IRF240	18	—	—	A	$V_{DS} > I_{D(on)} \times R_{DS(on) \text{ max.}}$, $V_{GS}=10V$
		IRF241	—	—	—	—	
		IRF242 IRF243	16	—	—	A	
Static Drain-Source On-State Resistance (2)	$R_{DS(on)}$	IRF240	—	0.13	0.18	Ω	$V_{GS}=10V$, $I_D=10A$
		IRF241	—	—	—	—	
		IRF242 IRF243	—	0.20	0.22	Ω	
Forward Transconductance (2)	g_{fs}	ALL	6.0	9.5	—	S	$V_{DS} > I_{D(on)} \times R_{DS(on) \text{ max.}}$, $I_D=10A$
Input Capacitance	C_{iss}	ALL	—	1200	1600	pF	$V_{GS}=0V$, $V_{DS}=25V$, $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	ALL	—	360	750	pF	
Reverse Transfer Capacitance	C_{rss}	ALL	—	130	300	pF	
Turn-On Delay Time	$t_{d(on)}$	ALL	—	—	30	ns	$V_{DD}=0.5BV_{DSS}$, $I_D=10A$, $Z_\theta=4.7^\circ\text{C/W}$ (MOSFET switching times are essentially independent of operating temperature.)
Rise Time	t_r	ALL	—	—	60	ns	
Turn-Off Delay Time	$t_{d(off)}$	ALL	—	—	80	ns	
Fall Time	t_f	ALL	—	—	60	ns	
Total Gate Charge (Gate-Source Plus Gate-Drain)	Q_g	ALL	—	44	60	nC	$V_{GS}=10V$, $I_D=22A$, $V_{DS}=0.8 \text{ Max. Rating}$ (Gate charge is essentially independent of operating temperature.)
Gate-Source Charge	Q_{gs}	ALL	—	9	—	nC	
Gate-Drain ("Miller") Charge	Q_{gd}	ALL	—	35	—	nC	

THERMAL RESISTANCE

Junction-to-Case	R_{thJC}	ALL	—	—	1.0	K/W	
Case-to-Sink	R_{thCS}	ALL	—	0.1	—	K/W	Mounting surface flat, smooth, and greased
Junction-to-Ambient	R_{thJA}	ALL	—	—	30	K/W	Free Air Operation

Notes: (1) $T_J=25^\circ\text{C}$ to 150°C (2) Pulse test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

(3) Repetitive rating: Pulse width limited by max. junction temperature

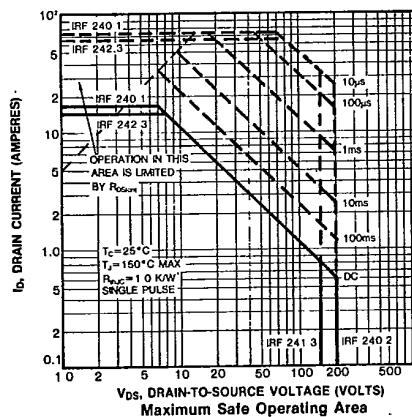
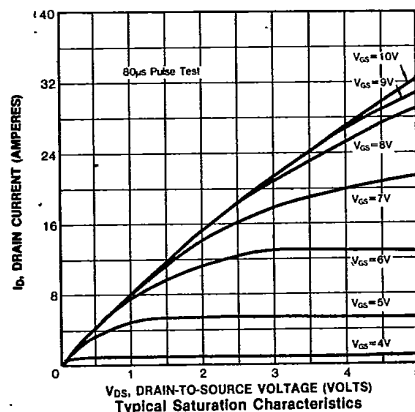
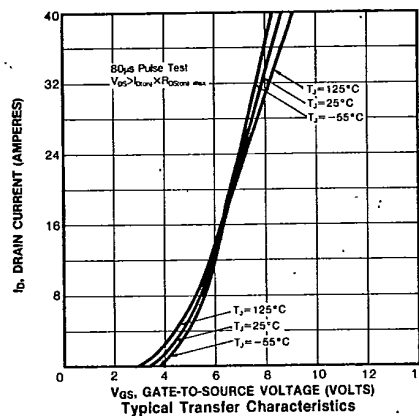
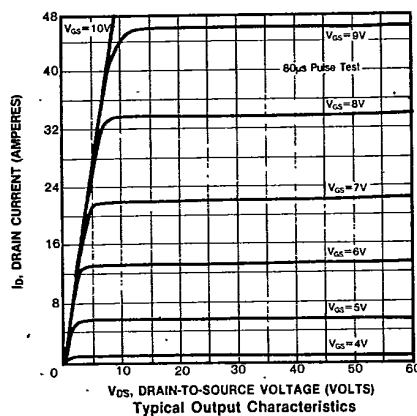


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IRF240/241/242/243**N-CHANNEL
POWER MOSFETS****SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

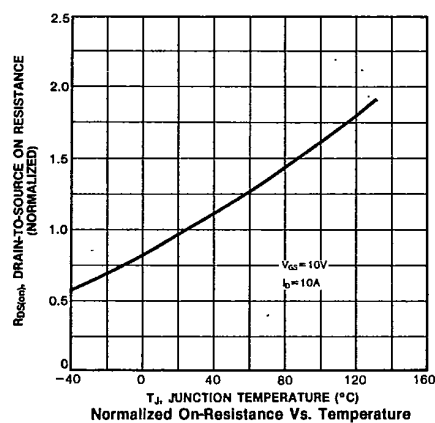
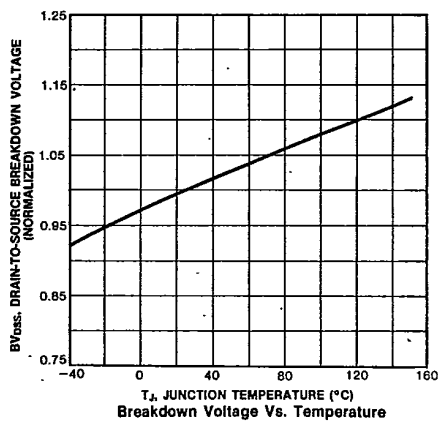
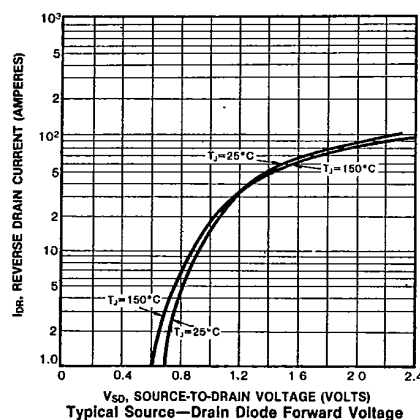
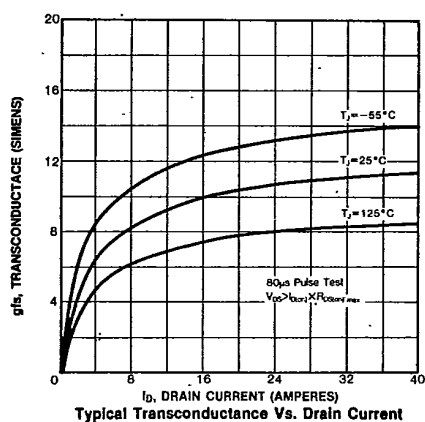
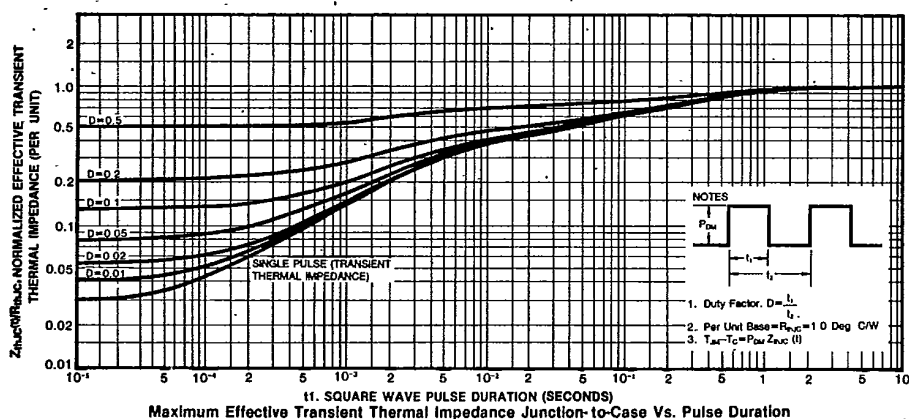
Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Continuous Source Current (Body Diode)	I_S	IRF240	—	—	18	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier
		IRF241	—	—	16	A	
		IRF242 IRF243	—	—	16	A	
Pulse Source Current (Body Diode) (3)	I_{SM}	IRF240	—	—	72	A	
		IRF241	—	—	64	A	
		IRF242 IRF243	—	—	64	A	
Diode Forward Voltage (2)	V_{SD}	IRF240	—	—	2.0	V	$T_C=25^\circ\text{C}$, $I_S=18\text{A}$, $V_{GS}=0\text{V}$
		IRF241	—	—	1.9	V	$T_C=25^\circ\text{C}$, $I_S=16\text{A}$, $V_{GS}=0\text{V}$
		IRF242 IRF243	—	—	1.9	V	$T_C=25^\circ\text{C}$, $I_S=16\text{A}$, $V_{GS}=0\text{V}$
Reverse Recovery Time	t_{rr}	ALL	—	650	—	ns	$T_J=150^\circ\text{C}$, $I_F=18\text{A}$, $dI_F/dt=100\text{A}/\mu\text{s}$

Notes: (1) $T_J=25^\circ\text{C}$ to 150°C (2) Pulse test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
 (3) Repetitive rating: Pulse width limited by max. junction temperature



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IRF240/241/242/243

N-CHANNEL
POWER MOSFETS

IRF240/241/242/243

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